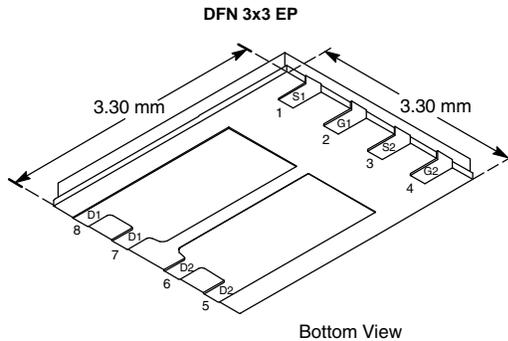


## SiS9122DN-VB Datasheet

### Dual N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY			
$V_{DS}$ (V)	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A) <sup>f</sup>	$Q_g$ (Typ.)
100	0.071 at $V_{GS} = 10$ V	12.1	3.3 nC
	0.076 at $V_{GS} = 7.5$ V	11.8	
	0.086 at $V_{GS} = 6$ V	10.9	



#### FEATURES

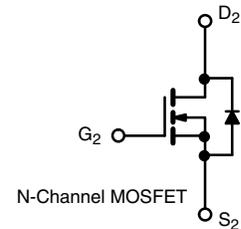
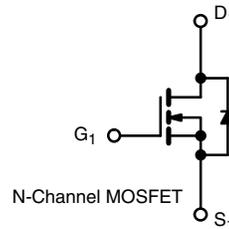
- TrenchFET<sup>®</sup> Power MOSFET
- 100 %  $R_g$  and UIS Tested

#### APPLICATIONS

- DC/DC Conversion
- Primary side switch
- Synchronous Rectification
- Industrial
- 48 V Battery Monitoring
- LED Driver



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**



ABSOLUTE MAXIMUM RATINGS ( $T_A = 25$ °C, unless otherwise noted)			
Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current ( $T_J = 150$ °C)	$I_D$	$T_C = 25$ °C	12.1
		$T_C = 70$ °C	9.7
		$T_A = 25$ °C	4.1 <sup>a, b</sup>
		$T_A = 70$ °C	3.2 <sup>a, b</sup>
Pulsed Drain Current ( $t = 300$ $\mu$ s)	$I_{DM}$	20	A
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25$ °C	20
		$T_A = 25$ °C	2.3 <sup>a, b</sup>
Single Pulse Avalanche Current	$I_{AS}$	7	
Single Pulse Avalanche Energy	$E_{AS}$	2.5	mJ
Maximum Power Dissipation	$P_D$	$T_C = 25$ °C	25
		$T_C = 70$ °C	16
		$T_A = 25$ °C	2.8 <sup>a, b</sup>
		$T_A = 70$ °C	1.8 <sup>a, b</sup>
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) <sup>c, d</sup>		260	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>a, e</sup>	$t \leq 10$ s	$R_{thJA}$	35	44	°C/W
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	4	5	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b.  $t = 10$  s.

c. The DFN3x3 package is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection

d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

e. Maximum under steady state conditions is 94 °C/W.

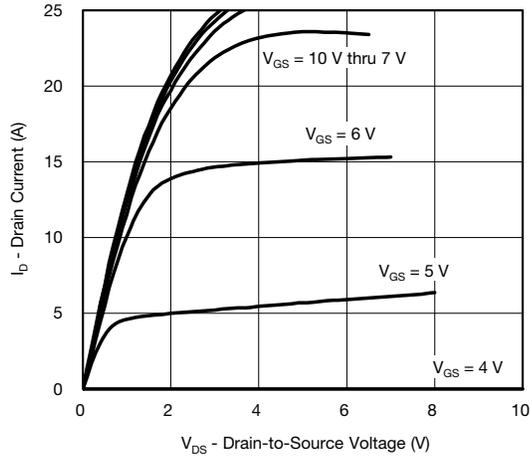
f. Based on  $T_C = 25$  °C.

<b>SPECIFICATIONS</b> ( $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	100			V	
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$		61		mV/ $^\circ\text{C}$	
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			-6.2			
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	2.5		4	V	
Gate-Source Leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			$\pm 100$	nA	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}$			1	$\mu\text{A}$	
		$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$			10		
On-State Drain Current <sup>a</sup>	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$	8			A	
Drain-Source On-State Resistance <sup>a</sup>	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 8\text{ A}$		0.071		$\Omega$	
		$V_{GS} = 7.5\text{ V}, I_D = 6\text{ A}$		0.076			
		$V_{GS} = 6\text{ V}, I_D = 4\text{ A}$		0.086			
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 15\text{ V}, I_D = 8\text{ A}$		11		S	
<b>Dynamic<sup>b</sup></b>							
Input Capacitance	$C_{iss}$	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$		250		pF	
Output Capacitance	$C_{oss}$			73			
Reverse Transfer Capacitance	$C_{rss}$			7			
Total Gate Charge	$Q_g$	$V_{DS} = 50\text{ V}, V_{GS} = 10\text{ V}, I_D = 10\text{ A}$		5.2	8	nC	
		$V_{DS} = 50\text{ V}, V_{GS} = 7.5\text{ V}, I_D = 10\text{ A}$		4	6		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 50\text{ V}, V_{GS} = 6\text{ V}, I_D = 10\text{ A}$		3.3	5		
			Gate-Drain Charge	$Q_{gd}$			1.4
Output Charge	$Q_{oss}$				$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		
			Gate Resistance	$R_g$	$f = 1\text{ MHz}$		1
Turn-On Delay Time	$t_{d(on)}$				$V_{DD} = 50\text{ V}, R_L = 5\text{ }\Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 7.5\text{ V}, R_g = 1\text{ }\Omega$		8
Rise Time	$t_r$			8		16	
Turn-Off Delay Time	$t_{d(off)}$		8	16			
Fall Time	$t_f$		6	12			
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 50\text{ V}, R_L = 5\text{ }\Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\text{ }\Omega$		7		14	
Rise Time	$t_r$			7		14	
Turn-Off Delay Time	$t_{d(off)}$			8		16	
Fall Time	$t_f$			5		10	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25\text{ }^\circ\text{C}$			20	A	
Pulse Diode Forward Current	$I_{SM}$				20		
Body Diode Voltage	$V_{SD}$	$I_S = 4\text{ A}, V_{GS} = 0\text{ V}$		0.87	1.2	V	
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 5\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$		30	60	ns	
Body Diode Reverse Recovery Charge	$Q_{rr}$			27	54	nC	
Reverse Recovery Fall Time	$t_a$			16		ns	
Reverse Recovery Rise Time	$t_b$			14			

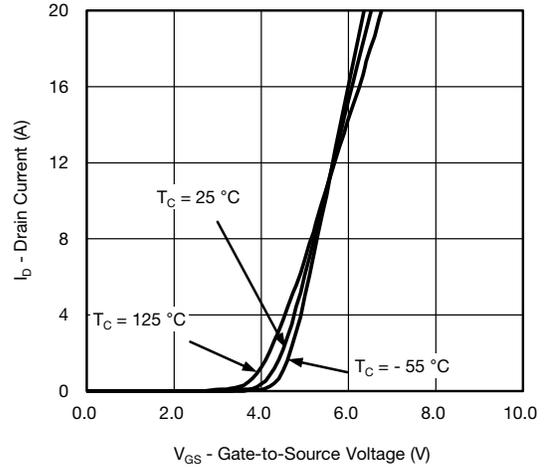
Notes:

- a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .  
 b. Guaranteed by design, not subject to production testing.

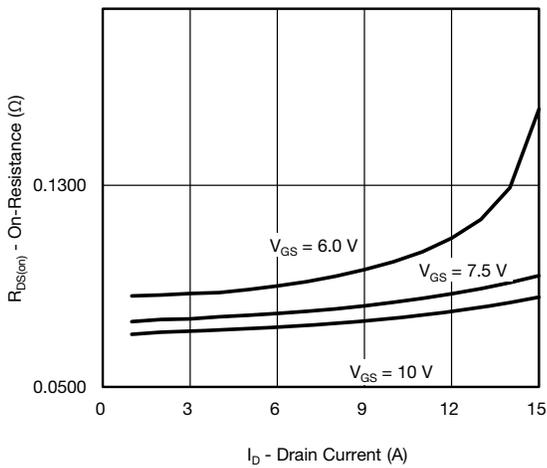
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



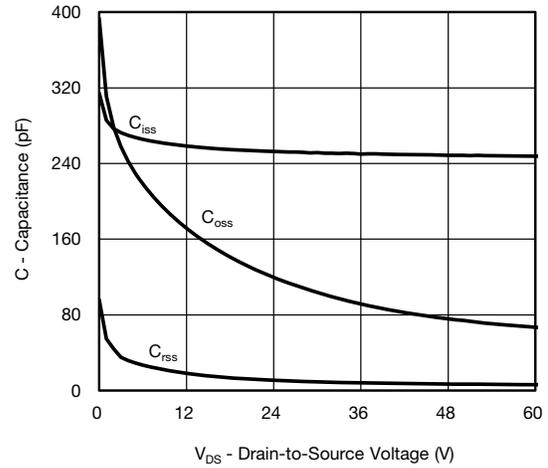
**Output Characteristics**



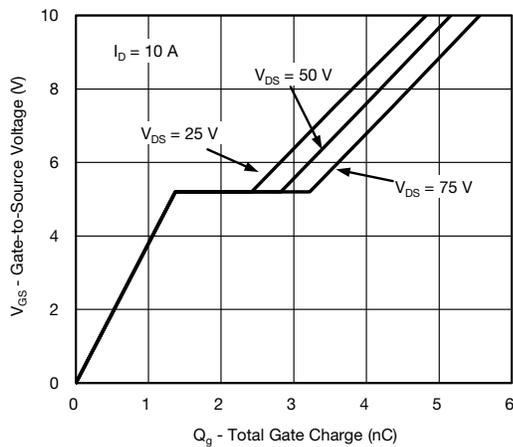
**Transfer Characteristics**



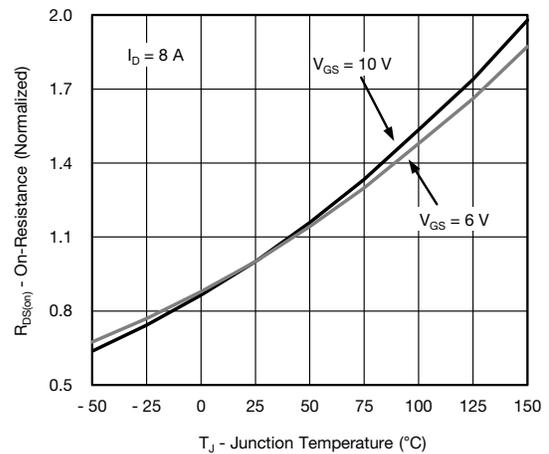
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**

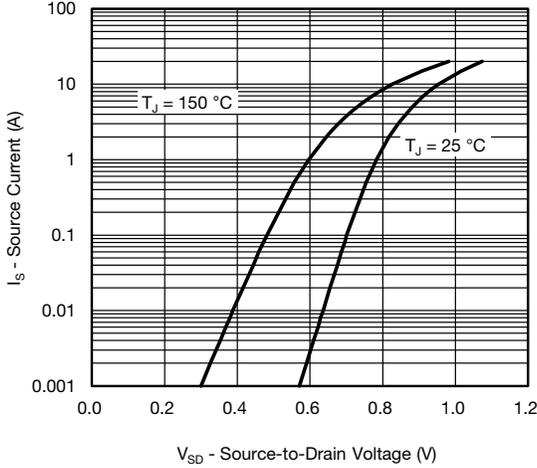


**Gate Charge**

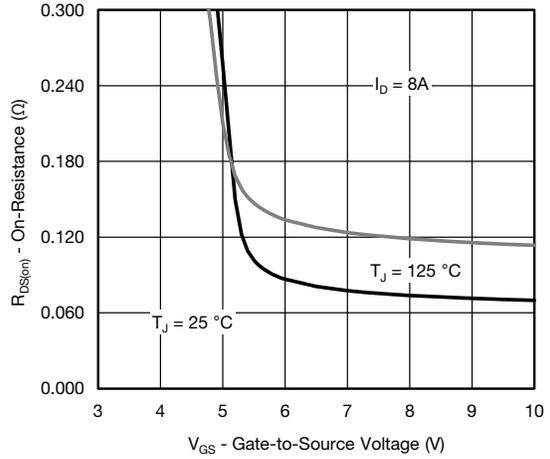


**On-Resistance vs. Junction Temperature**

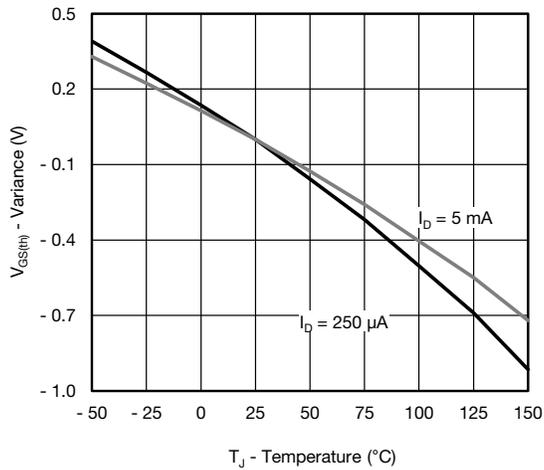
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



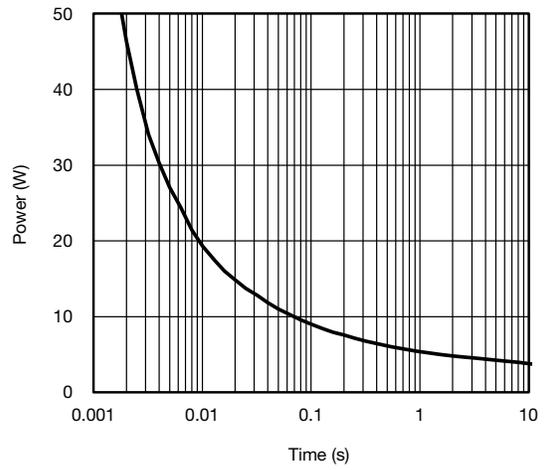
**Source-Drain Diode Forward Voltage**



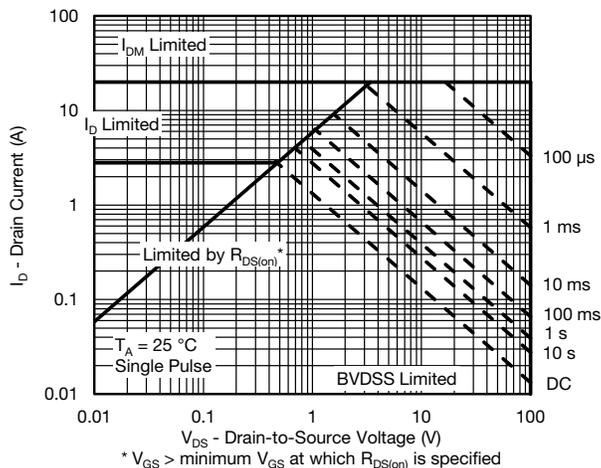
**On-Resistance vs. Gate-to-Source Voltage**



**Threshold Voltage**

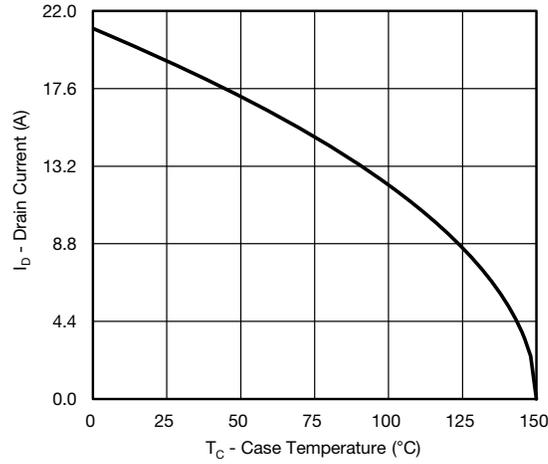


**Single Pulse Power, Junction-to-Ambient**

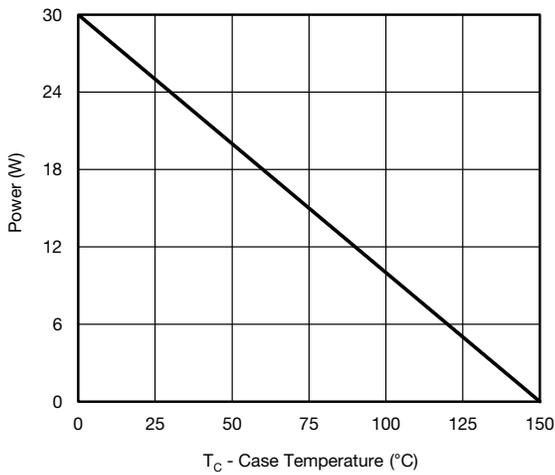


**Safe Operating Area, Junction-to-Ambient**

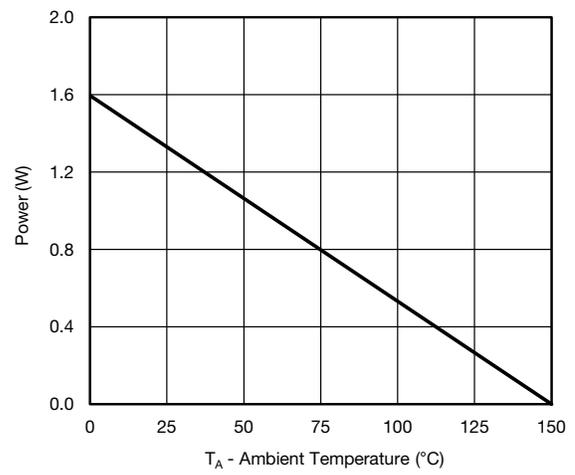
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



**Current Derating\***



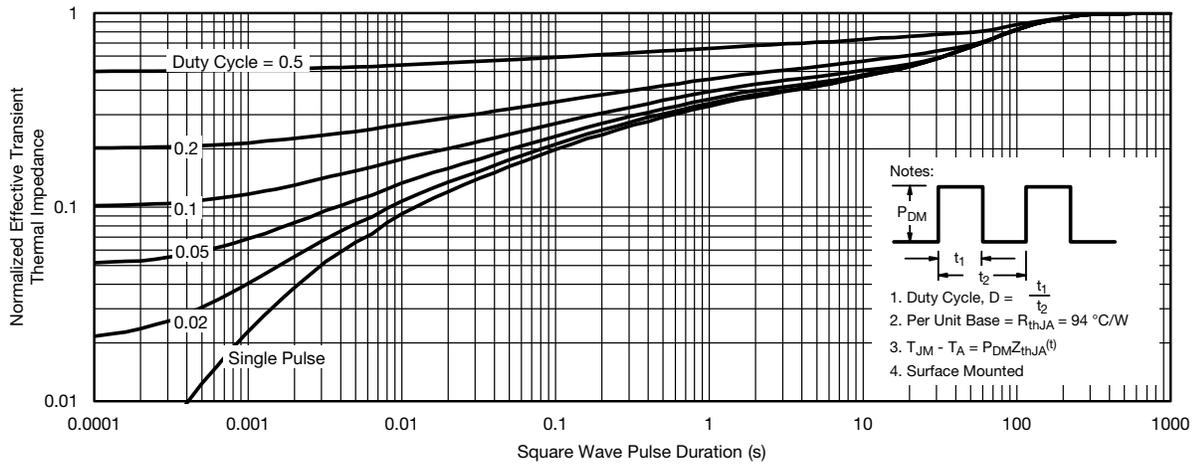
**Power, Junction-to-Case**



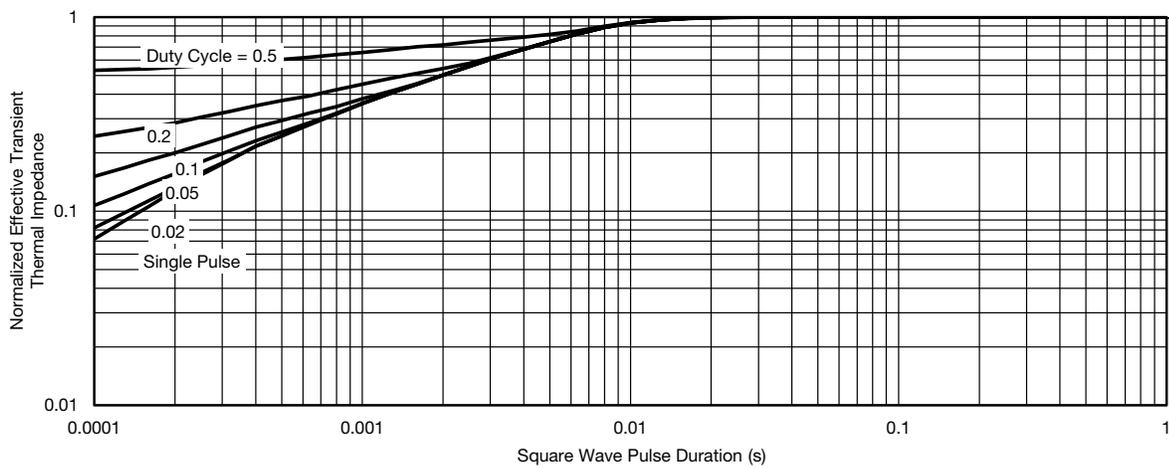
**Power, Junction-to-Ambient**

\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

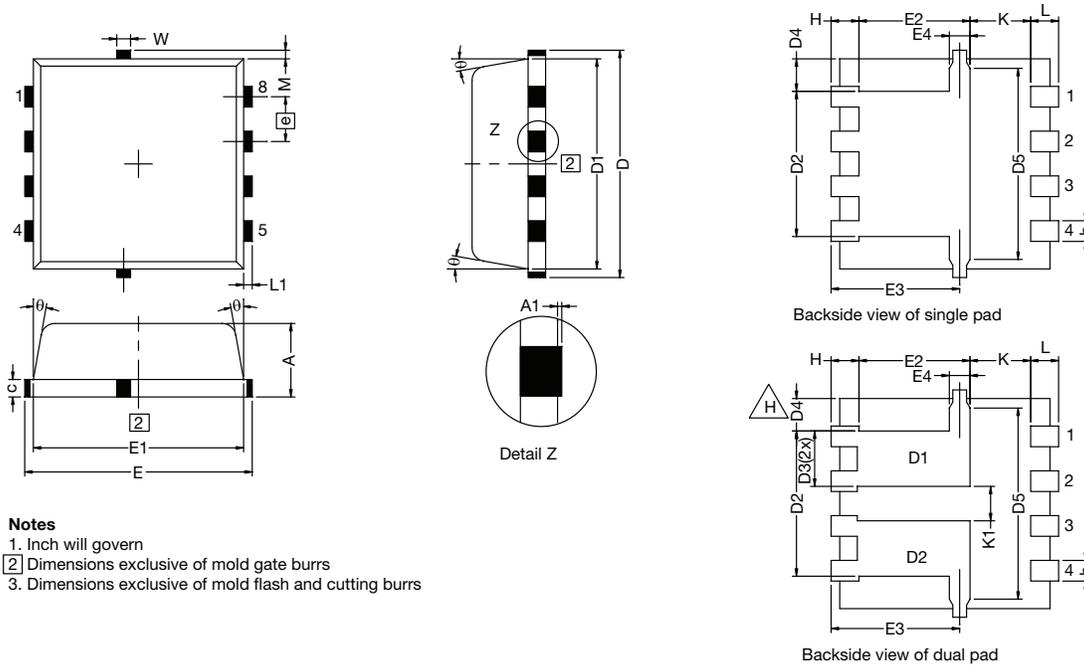


**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Case**

## DFN3x3, (Single / Dual)

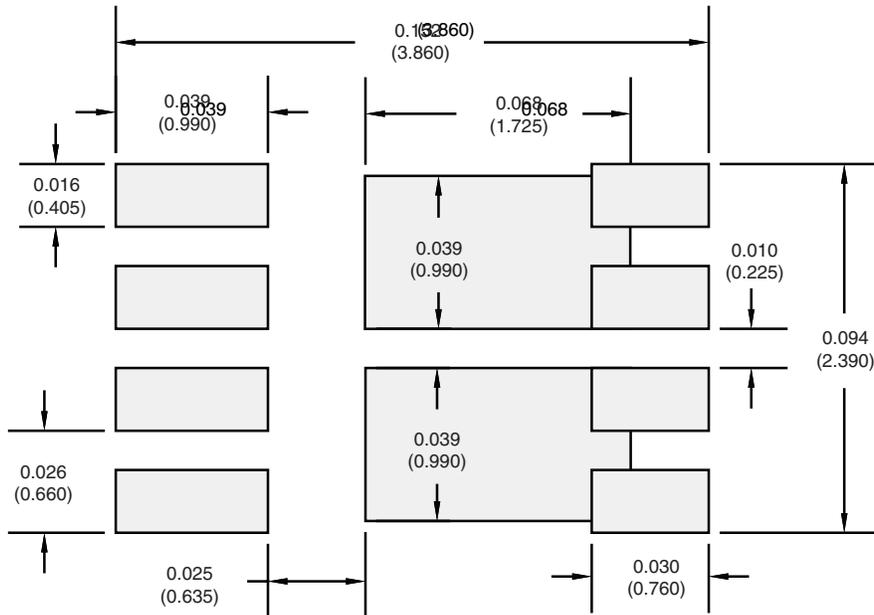


- Notes**
1. Inch will govern
  2. Dimensions exclusive of mold gate burrs
  3. Dimensions exclusive of mold flash and cutting burrs

DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.97	1.04	1.12	0.038	0.041	0.044
A1	0.00	-	0.05	0.000	-	0.002
b	0.23	0.30	0.41	0.009	0.012	0.016
c	0.23	0.28	0.33	0.009	0.011	0.013
D	3.20	3.30	3.40	0.126	0.130	0.134
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
D3	0.48	-	0.89	0.019	-	0.035
D4	0.47 typ.			0.0185 typ		
D5	2.3 typ.			0.090 typ		
E	3.20	3.30	3.40	0.126	0.130	0.134
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	1.75	1.85	1.98	0.069	0.073	0.078
E4	0.034 typ.			0.013 typ.		
e	0.65 BSC			0.026 BSC		
K	0.86 typ.			0.034 typ.		
K1	0.35	-	-	0.014	-	-
H	0.30	0.41	0.51	0.012	0.016	0.020
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
$\theta$	0°	-	12°	0°	-	12°
W	0.15	0.25	0.36	0.006	0.010	0.014
M	0.125 typ.			0.005 typ.		

ECN: S16-2667-Rev. M, 09-Jan-17  
DWG: 5882

RECOMMENDED MINIMUM PADS FOR DFN 3x3 Dual



Recommended Minimum PADS for PowerPAK 1212-8 Dual  
Dimensions in Inches/(mm)

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